AFRL-SR-BL-TR-98-

Standard Form 298 (Rev. 2-89) Prescribed by ANSI Std. 235-18

3341

REPORT DOCUMENTATION PAGE

AGENCY USE ONLY (Leave blank)	2. REPORT DATE	3. REPORT TYPE AND	unces, along this burden estimate or any other assets of this histories on Operations and Reports, 1215 sefterion int (0/04-0163), Weshington, DC 20503
AGENCY USE DRET (LEAVE STATE)		F inal 01 Jul	97 to 31 Dec 97 5. FUNDING NUMBERS
TITLE AND SUSTIFLE BMDO SBIR-97 Subnanose	ocond liltma Low I	Povor Concumntion	5. FUNDING RUMBERS
3-Dimensional NB RAM	econd offia-row i	rower consumption	62173C
o bimonsional no man			1660/01
AUTHOR(S)		>-	•
Dr Kirichenko			
PERFORMING ORGANIZATION NAM	E(S) AND ADDRESS(ES)		E. PERFORMING ORGANIZATION REPORT NUMBER
Hypres Inc			
170 Clearbrook Road		•	
Elmsford NY 10523			
			· · · · · · · · · · · · · · · · · · ·
SPONSORING/MONITORING AGENC	Y NAME(S) AND ADDRESS	(11)	10. SPONSORING/MONITORING AGENCY REPORT NUMBER
AFOSR/NE			
110 Duncan Road RMB115	5	*1	F49620-97-C-0031
Bolling AFB DC 20332-8			
APPROVAL FOR PUBLIC RE	JEROLD. DIDINOBO	J. On Ondirii ibb	
. ABSTRACT (Maximum 200 words)			
A comprehensive study architectures has been block-access RAM archi RAM cell have been eva	conducted. The tecture with an Juated by simula	result of this s access time - 300 ton. Two differ	erconductive RAM tudy is a novel ps. Several types of ent types of these RAM
A comprehensive study architectures has been block-access RAM archi RAM cell have been eva	conducted. The tecture with an Juated by simula	result of this s access time - 300 t on. Two differ ed.	tudy is a novel ps. Several types of ent types of these RAM
A comprehensive study architectures has been block-access RAM archi RAM cell have been eva	conducted. The tecture with an Juated by simula	result of this s access time - 300 t on. Two differ ed.	tudy is a novel ops. Several types of
A comprehensive study architectures has been block-access RAM archi RAM cell have been eva cells have been experi	conducted. The tecture with an Juated by simula	result of this s access time - 300 t on. Two differ ed.	tudy is a novel ps. Several types of ent types of these RAM
A comprehensive study architectures has been block-access RAM archi RAM cell have been eva cells have been experi	conducted. The tecture with an Juated by simula	result of this s access time - 300 t on. Two differ ed.	ps. Several types of ent types of these RAM
A comprehensive study architectures has been block-access RAM archi RAM cell have been eva cells have been experi	conducted. The tecture with an Juated by simula	result of this s access time - 300 t on. Two differ ed.	ps. Several types of ent types of these RAM
A comprehensive study architectures has been block-access RAM archi RAM cell have been eva cells have been experi	conducted. The tecture with an Juated by simula	result of this s access time - 300 t on. Two differ ed.	ps. Several types of ent types of these RAM
A comprehensive study architectures has been block-access RAM archi RAM cell have been evacells have been experi	conducted. The tecture with an Juated by simula	result of this s access time - 300 t on. Two differ ed.	ps. Several types of ent types of these RAM

NSN 7540-01-280-5500

SMALL BUSINESS INNOVATION RESEARCH BMDO

PHASE I FINAL REPORT

CONTRACT # F49620-97-C-0031

SUBNANOSECOND ULTRA LOW POWER CONSUMPTION THREE-DIMENSIONAL RAM

TECHNICAL MONITOR

Dr. Harold Weinstock

US Air Force Office of Scientific Research

(202)767-4933

PRINCIPAL INVESTIGATOR:

Alex Kirichenko

HYPRES, Inc.

175 Clearbrook rd. Elmsford, NY, 10523

PHONE:

(914) 592-1190 x7853

FAX:

(914) 347-2239

E-MAIL:

alex@hypres.com

Supported by Ballistic Missile Defense Organization/Science and Technology and managed by US Air Force Office of Scientific Research

1. Summary of Accomplishments

The goal of this Phase I SBIR program is to demonstrate feasibility of a 3-dimensional RAM based on superconductive digital electronics. The project goal has been successfully achieved. Specifically, HYPRES performed the following tasks:

- 1. A comprehensive study of possible high-performance superconductive RAM architectures has been conducted. The result of this study is a novel block-access RAM architecture with an access time ~ 300 ps.
- 2. Several types of RAM cell have been evaluated by simulation. Two different types of these RAM cells have been experimentally evaluated.
- 3. As a result of this study, the novel RAM cell with non-destructive readout has also been designed and evaluated. It exploits three shunted Josephson junctions and has good parameter margins (more than $\pm .32$ %). The size of the RAM cell (50x45 μ m² for HYPRES' 3.5 μ m fabrication process) allows us to place a 16 Kbit RAM matrix on a 1x1 cm² chip.
- 4. A new control current driver has been designed, fabricated, and successfully tested. The current driver works with +/- 9% DC bias current margins.
- 5. In order to assess the feasibility of a 3D memory module, the interconnection between stacked chips has been designed and fabricated. A chip-to-chip pulse transfer experiment has been carried out. We have successfully observed SFQ pulse propagation through laser drilled holes in a chip at low frequency.
- 6. Exceeding the Phase I objectives, we have also developed a novel random access memory concept called Deep Pipeline RAM (DPRAM). This RAM is a full pipeline structure and has an extremely low cycle time (below 30 ps).

2. Description of Work Performed

1.1 Development of a RAM architecture

The first objective of the Phase I was to refine the proposed RAM architecture. We have conducted an exclusive study to find the best solution to build at least 16 Kbit RAM with sub-nanosecond access time, suitable for 3D packaging. As a result, a novel block-access RAM architecture has been developed (Fig. 1)

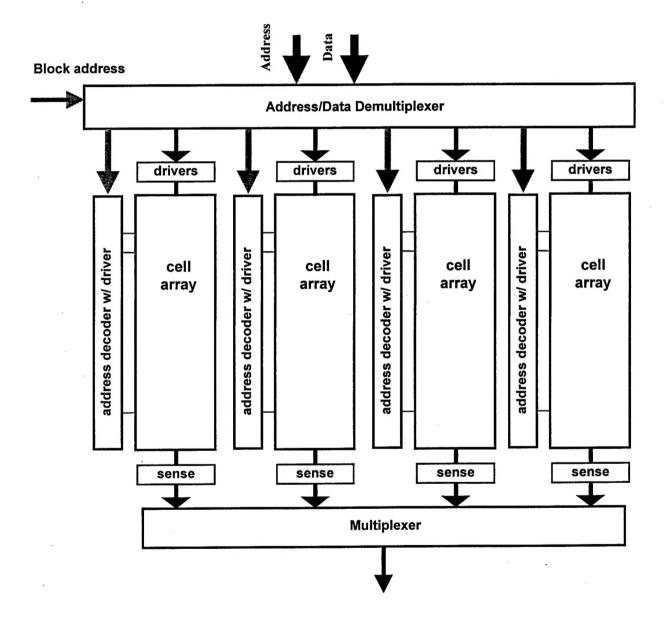


Fig. 1. Block diagram of 16 Kbit RAM chip, using a novel block-access architecture.

The block-access non-destructive readout superconductive RAM is shown in Fig. 1. The basic feature of this RAM is its row-access. Instead of individual bits, the proposed RAM stores the 32-bit words. The 16 Kbit 1x1 cm² RAM chip consists of 4 blocks. Each block has 128x32 RAM matrix with a row access. The incoming data and addresses go through the Y demultiplexer to a corresponding block, according to the first two bits of address. After that, the rest of the address (7 bits) goes to a row decoder and selects the corresponding row. The W/R bit sets the direction of current in the X select line. The 32-bit data indicates the WRITE operation and goes in parallel through the Y-select lines, writing down a word to the selected row. The address decoder and demultiplexer are based on a Rapid Single-Flux Quantum (RSFQ) logic.

The speed of signal propagation along the superconductive microstrip line in the case of SiO_2 insulator is 0.3 c, where c is a speed of light. It gives us a signal propagation delay time of about 50 ps. The estimated access time of this RAM (including the delays in decoders) is 300 ps.

The advantages of this architecture are:

- The row access simplifies the RAM cell reducing its size.
- The RSFQ decoders do not need to be driven by AC currents, thus reducing power dissipation and crosstalk, allowing the opportunity for 3D packaging.
- The signal propagates along impedance matched microstrip lines near the speed of light, reducing latencies and access times.
- The non-destructive readout and non-volatile cell characteristics eliminate the need for a REFRESH operation, which dynamic RAMs require, reducing the cycle time.
- The block-access allows us to transfer data in and out the chip in parallel, increasing the efficiency of the lower performance chip-to-chip interface.

1.2 Evaluation of RAM cells

We have both theoretically and experimentally evaluated the version of the RSFQ RAM cell suggested in Phase I proposal (Fig. 2). We have encountered some effects, which can not be taken into account during simulation.

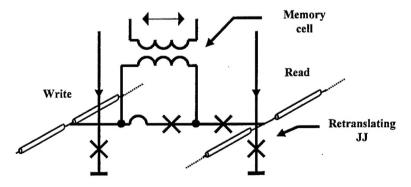


Fig. 2 The schematics of memory cell suggested in Phase I proposal.

Specifically, the testing results of a 2x5 RAM cell array (Fig. 3) have indicated poor DC bias current margins resulting in bad yield of cells. Just four of ten cells were fully functional within very narrow DC bias current margins.

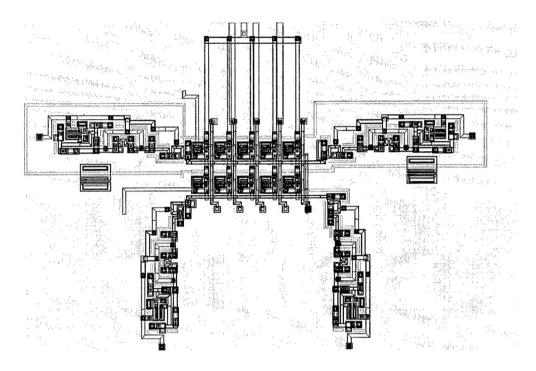


Fig. 3. Layout of a 2x5 memory cell array with floating grounds and common bias lines.

As a result, we have made the following conclusions:

- The floating ground approach complicates design and reduces parameter margins.
- Propagation of SFQ pulses through the Josephson transmission line (JTL) is not efficient. The delay of pulse propagation can not be compensated by microstrip capacitance and is unacceptably large.
- A non-destructive readout and non-volatile RAM cell would eliminate the need for REFRESH operation reducing the cycle time.

1.3 A novel non-destructive readout RAM cell

After careful investigation we have developed new RAM concept (Fig. 1). A proposed cell for this architecture is shown in Fig. 4.

We have designed, fabricated, and experimentally evaluated a new version of the superconductive RAM cell. This NDRO cell consists of three shunted Josephson junctions comprising two interferometers with a common inductance (Fig. 4). The

single-junction interferometer serves as a storage loop, while the two-junction interferometer serves as a readout SQUID.

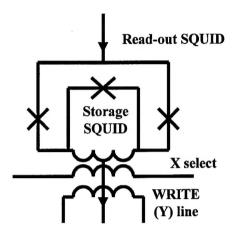


Fig. 4 Schematic of a new NFRO memory cell.

The row-access architecture allows us to get rid of one extra select line reducing the space occupied by the cell, while also solving the half-select problem. The truth table for the RAM cell operation is as following. The sign before the select line name indicates the control current direction.

Table 1. Truth Table for NDRO RAM Design

Operation	Select lines	Access
WRITE 1	+X +Y	Each cell
WRITE 0	-X	Entire row
READ	+X	Entire row

All cells in a column are sequentially connected. The DC current flows through the readout SQUIDs. A sensing device is placed at the end of each column. If the SQUID switches to resistive state during the READ operation, the sensing device will indicate a signal and transform it into an SFQ pulse.

Experimental evaluation shows excellent margins for this cell. The minimal critical current margin is 32%. The minimal control current amplitude margin is above 50%. The DC bias current of readout SQUIDs has 36% margins. Moreover, the simplicity and reliability of this cell are very suitable for the large integration scale memories.

1.4 The dc Current Driver

We have designed, fabricated, and successfully tested an amplifier based on the current driver proposed in this project. Fig. 5 shows a schematic of this circuit. The large inductance loop is connecting two relaxation-oscillations driven pairs of unshunted Josephson junctions. The dc current from the current source is being pushed into and out of the inductance loop, which is magnetically coupled to dc SQUIDs chain. Fig. 6 shows successful test results of the amplifier based on DC current drivers.

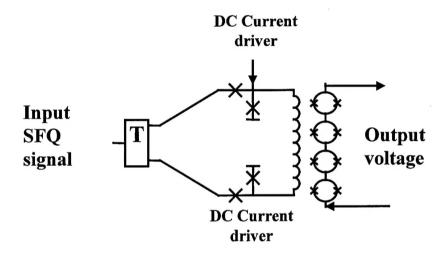


Fig. 5. Output amplifier based on DC current drivers.

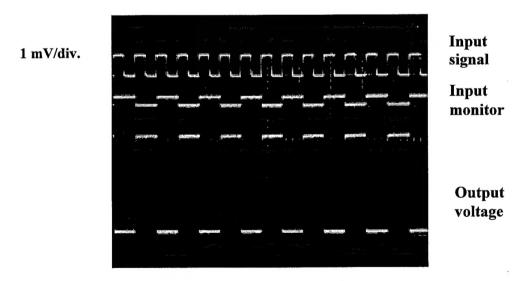


Fig. 6. Low-frequency test results of output amplifier. The output voltage amplitude is 3 mV, in contrast to the custom monitor (0.2 mV)

1.5 Chip-to-chip data transfer

We have proposed, designed and tested a novel method to implement chip-to-chip interconnection, using holes made by a laser-drilling technique. Fig. 7 shows the idea proposed in Phase I to experiment with chip-to-chip SFQ pulse propagation.

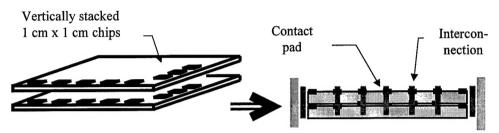


Fig. 7. The Phase I experiment on chip-to-chip data transfer.

To provide interconnections with uniform impedance we proposed to drill holes of about 0.2 mm in diameter in the vertically stacked chips. Fig. 8 shows microphotographs of chips with holes made by Laser Light Technology, Inc. (Missouri). Fig. 8a shows a microphotograph of a hole made through the metal layer. Due to the reflection of laser irradiation from the metal surface, edges of the hole have numerous defects. As a result, the contact pad is damaged and cannot be soldered to a wire. We have found that for better quality all metal layers from the place assigned for the hole should be removed during the fabrication process. We have designed special contact pads with free-of-metal targets for the laser drilling. Fig. 8b shows the result of laser drilling through the silicon substrate without any metal layer. In the center of a contact pad one can see the round targets, where all metal layers were removed.

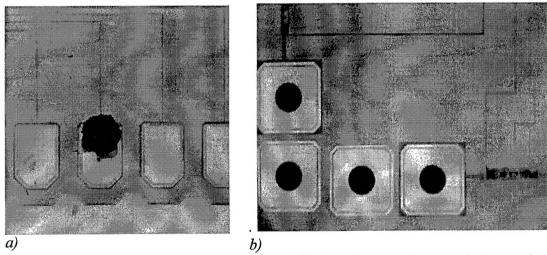


Fig. 8 Microphotographs of 0.2 mm holes drilled in chip with laser technique, when (a) The holes were drilled through the metal layers and (b) the metal layers were pre removed.

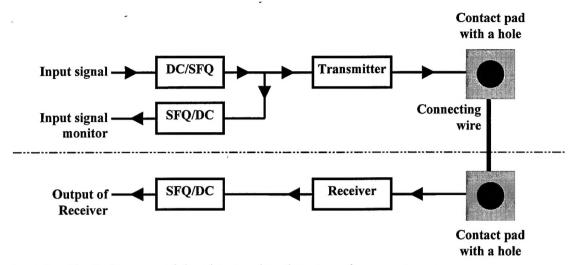


Fig. 9. Block-diagram of the chip-to-chip data transfer experiment.

The block-diagram of our experiment with a chip-to-chip data transfer is shown on Fig. 9. We have designed a transmitter capable of amplifying SFQ pulse to the level, sufficient to transfer this pulse through the chip-to-chip interconnection and to be sensed by a sensitive receiver on another chip.

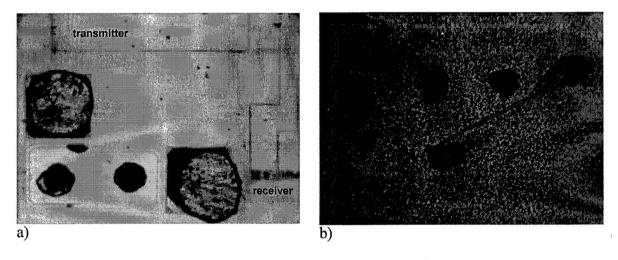


Fig. 10. The front (a) and the bottom (b) side of a chip with soldered wire connecting two contact pads through the 200 µm holes.

Fig. 9 shows microphotographs of a HYPRES chip with laser drilled holes connected to gold wire. We have soldered a 50- μ m wire to the contact pads. On Fig. 10(a) one can see the indium bumps. On the bottom view of chip (Fig. 10(b)) one can see a 50 μ m diameter gold wire connecting receiver and transmitter pads. The resistance of this wire was 1.2 Ω at room temperature.

Fig. 11 shows low-frequency testing results. The most critical receiver's dc bias current margins were ± 9 %. The estimated maximum operational frequency of this interconnection is about 3 GHz.

1.6 Deep Pipeline Random Access Memory

In order to reduce memory cycle time, we can use a pipelined approach. This pipeline structure requires extra circuitry, which occupies more space on the chip, but dramatically reduces the cycle time. The proposed Deep-Pipeline RAM (DPRAM) operates in a block access mode. It contains a fully pipelined address decoder and a memory matrix consisting of pipelined rows. The number of rows corresponds to the size of the block (Fig. 12). To achieve a 30 ps cycle time for 128x32 memory array, the matrix block is divided into four pipeline stages. Each stage is connected to another using timed repeaters.

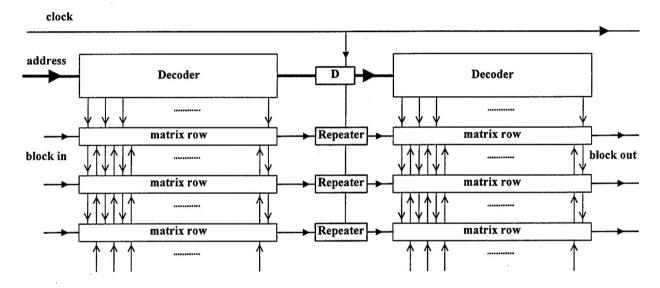


Fig. 12. Block-diagram of DPRAM.

In this RAM, data moves in the rows synchronously with address in the decoder. When an address reaches the designated column, the decoder sends a signal to the column, which reads a word stored in the memory cells of this column into the repeater. Thus, we have a fully pipelined RAM with cycle time equal to one clock period. The access time is a number of clock periods, corresponding to the number of pipeline stages. Therefore, reducing RAM capacity to 1 Kbit per 1 cm² chip, we can reduce the cycle time to 30 ps.

3. Conclusion

We have successfully demonstrated the feasibility of a superconductive, sub-nanosecond access time, three-dimensional random-access memory. We have developed a schematic of the 16 Kbit RAM chip with 300 ps access time and a schematic of the 1 Kbit Deep-Pipeline RAM with a cycle time below 30 ps. The components for the proposed RAM were designed, fabricated and successfully tested. We have designed a novel NDRO memory cell. Due to the novel architectural solution, this cell exploits only three Josephson junctions and has a size as small as 50 μ m x 54 μ m. We have successfully demonstrated the data propagation between two vertically stacked chips exploiting the laser drilling technique.

The achieved results provide us a solid foundation for rapid progress in Phase II of the project. HYPRES will upgrade its Nb fabrication process to $1.5 \mu m$ minimal feature size lithography. After that, we will be able to increase an integration scale of the proposed RAM to 64 Kbit per 1 cm chip.

The proposed RAM can provide a substantial performance improvement over existing and prospective semiconductor systems, sufficient to yield successful commercialization.